

**Notice of References Cited**

Application/Control No.

10/520,964

Applicant(s)/Patent Under  
Reexamination  
LENNARTZ ET AL.

Examiner

Fiona T. Powers

Art Unit

1626

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,066,969	06-2006	Lennartz et al.	8/673
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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	U	Fogg et al., Analytica Chimica Acta, 362(2-3), 235-240, 1998.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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